LPDDR4 Memory Interface Module - Lattice Radiant Software

User Guide

FPGA-IPUG-02154-1.1

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Acronyms in This Document
A list of acronyms used in this document.

<table>
<thead>
<tr>
<th>Acronym</th>
<th>Definition</th>
</tr>
</thead>
<tbody>
<tr>
<td>DDR</td>
<td>Double Data Rate</td>
</tr>
<tr>
<td>FPGA</td>
<td>Field Programmable Gate Array</td>
</tr>
<tr>
<td>LPDDR</td>
<td>Low-Power Double Data Rate</td>
</tr>
<tr>
<td>LSE</td>
<td>Lattice Synthesis Engine</td>
</tr>
</tbody>
</table>
1. Introduction

The Lattice Semiconductor Low Power Double Data Rate 4 (LPDDR4) Memory Interface Module generates a module that can be used to interface to an LPDDR Memory and includes a bidirectional port and the associated clocking scheme.

1.1. Quick Facts

Table 1.1 presents a summary of LPDDR4 Memory Module.

<table>
<thead>
<tr>
<th>IP Requirements</th>
<th>Supported FPGA Family</th>
<th>CertusPro™-NX</th>
<th>Targeted Devices</th>
<th>LFCPNX-100</th>
</tr>
</thead>
<tbody>
<tr>
<td>Resource Utilization</td>
<td>Supported User Interface</td>
<td>LPDDR4, Native interface – see Signal Description section.</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>Resources</td>
<td>See Table A.1.</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Design Tool Support</td>
<td>Lattice Implementation</td>
<td>Lattice Radiant™ software 3.0</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>Synthesis</td>
<td>Lattice Synthesis Engine (LSE)</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>Synopsys® Synplify Pro® for Lattice</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>Simulation</td>
<td>For a list of supported simulators, see the Lattice Radiant software user guide.</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

1.2. Features

Key features of Low Power Double Data Rate 4 (LPDDR4) Memory Module include:

- Supports LPDDR4 memory interface
- Frequency Supported: 200, 250, 300, 350, 400, 533 MHz
- Supports 8:1 (X4) gearing ratio
- Write Leveling support for LPDDR4
- DQ-DQS skew optimization for Write Training
- Dynamic valid window optimization (Read and Write Path)
- Configurable number of chip selects
- Configurable number of clocks
- Internal programmable Vref
- Includes PLL for clock generation
1.3. Conventions

1.3.1. Nomenclature
The nomenclature used in this document is based on Verilog HDL.

1.3.2. Signal Names
Signal names that end with:
- \_n are active low
- \_i are input signals
- \_o are output signals
- \_io are bi-directional input/output signals
2. Functional Description

2.1. Overview

LPDDR4 Memory Interface Module instantiates the DDR primitives to implement the necessary features for interfacing with LPDDR4 memory devices with data rates up to 1066Mbps. This module is used to pass commands and data signals from the FPGA fabric operating in system clock to the LPDDR4 memory device operating in the high-speed DDR clock. The LPDDR4 Memory Interface is operating on 8:1 gearing ratio or X4 gearing mode which means:

- The DDR clock (ddr_ck_o) frequency is 4x the system clock (sclk_o) frequency
- The bit width of data signal in system clock domain is equivalent to DDR DQ/DQS/DMI bit width x 8. Thus, it takes 4 ddr_ck_o cycles to transfer the data to/from system clock domain. Note that data is transferred on both ddr_ck_o edges.
- On the other hand, bit width of command/address signal in system clock domain is equivalent to DDR CKE/CS/CA/ODT bit width x 4. These signals are shifted out on ddr_ck_o falling edge and the external memory sample these on the rising edge.

This module is designed to be used with a memory controller as shown in Figure 2.1. The memory controller organizes the command and data signals in system clock domain and this module converts them to high-speed LPDDR4 signaling.

![Figure 2.1. LPDDR4 Memory Interface Application](image)
The top level block diagram of the LPDDR4 Memory Interface Module is shown in Figure 2.2. This shows that the bit width of command/address path signals in the memory controller side is 4x of the bit width of the corresponding memory the device-side signals. While bit width of data I/O path signals in the memory controller side is 8x of the bit width of the memory the device-side signals.

The command bus signals have configurable output delay signals per bit (Per Bit Delay Adj.) to support command bus training. The data I/O path on the other hand have two levels of delay adjustment: the Per DQS Grp. Delay Adj. and the Per Bit Delay Adj.

**Figure 2.2. DDR Memory Interface Module Block Diagram (No PLL Instance)**
2.2. Signal Description

Table 2.1 describes the LPDDR4 Memory Interface Module signals. The signals are grouped as follows:

- **Clock and Reset** – As the group name implies, these are clock and reset signals. This also includes the signal that controls the clock and indicates the clock ready status. Please refer to Clock Synchronization Logic section for more information on this group.

- **User Interface** – The LPDDR4 Controller uses this group to control the LPDDR4 Interface group in implementing the LPDDR4 protocol. Please refer to Data Input/Output Path and Command/Address Path sections for more information on this group.

- **Per DQS Group Delay Adjustment** – Implements delay adjustment for DQS-DQ read data path, DQS-DQ write data path and CK-DQS write data path (write leveling). A DQS group is composed of 8-bit of DQ and the corresponding DQS and DMI bit. Please refer to Training Support section for more information on this group.

- **Per Bit Delay Adjustment** – Implements delay per bit adjustment for the command bus (CS/CA). Please refer to Command Bus Training section for more information on this group.

**Note:** We are planning to remove the per bit delay adjustment on DQ/DMI signal.

### Table 2.1. LPDDR4 Memory Interface Module Signal Description

<table>
<thead>
<tr>
<th>Pin Name</th>
<th>Direction</th>
<th>Width (Bits)</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Clock and Reset</strong></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>pll_refclk_i</td>
<td>In</td>
<td>1</td>
<td>Reference clock input for PLL</td>
</tr>
<tr>
<td>pll_lock_o</td>
<td>Out</td>
<td>1</td>
<td>Signal from PLL indicating stable clock condition</td>
</tr>
<tr>
<td>rst_i</td>
<td>In</td>
<td>1</td>
<td>Active HIGH reset signal</td>
</tr>
<tr>
<td>sync_clk_i</td>
<td>In</td>
<td>1</td>
<td>Input clock that drives the soft logic that controls the PLL instance. You</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>should not connect to sclk_o because the sclk_o is stopped during clock</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>frequency change. If the PLL Reference Clock from Pin attribute is checked,</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>you should not connect this to pll_refclk_i.</td>
</tr>
<tr>
<td>sclk_o</td>
<td>Out</td>
<td>1</td>
<td>Output clock with frequency equal to DDR clock divided by 4</td>
</tr>
<tr>
<td>ddr_clk_sel_i</td>
<td>In</td>
<td>3</td>
<td>Selects the DDR clock frequency when performing clock frequency change.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>This signal must remain stable when clock_update_i asserts until ready_o</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>negates. 0: Operating frequency – DDR Memory Frequency attribute</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>1: Command Bus Training frequency – 50 MHz</td>
</tr>
<tr>
<td>dll_update_en_i</td>
<td>In</td>
<td>1</td>
<td>Enables DLL update during clock frequency change. DLL update has long delay</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>This it is recommended to only perform DLL update on the final clock</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>frequency change of command bus training.</td>
</tr>
<tr>
<td>clk_update_i</td>
<td>In</td>
<td>1</td>
<td>A transition from LOW to HIGH triggers the clock frequency change</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>according to ddr_clk_sel_i signal. This signal must remain stable until</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>ready_o goes HIGH again.</td>
</tr>
<tr>
<td>ddr_ck_en_i</td>
<td>In</td>
<td>1</td>
<td>Enables the clock toggling of ddr_ck_o</td>
</tr>
<tr>
<td>ready_o</td>
<td>Out</td>
<td>1</td>
<td>Indicates internal DDR clock and sclk_o are stable and ready to operate.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>This signal negates during clock frequency change and asserts again when</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>both DDR clock and sclk_o are valid for the new frequency setting.</td>
</tr>
<tr>
<td><strong>LPDDR4 User Interface</strong></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>ck_oe_n_i</td>
<td>In</td>
<td>1</td>
<td>Tristate control port for CK/CKE</td>
</tr>
<tr>
<td>cke_i</td>
<td>In</td>
<td>4</td>
<td>Clock Enable input</td>
</tr>
<tr>
<td>ca_oe_n_i</td>
<td>In</td>
<td>1</td>
<td>Tristate control port for CS/CA/ODT</td>
</tr>
<tr>
<td>cs_i</td>
<td>In</td>
<td>4</td>
<td>Chip Select input</td>
</tr>
<tr>
<td>ca_i</td>
<td>In</td>
<td>24</td>
<td>Command/Address input</td>
</tr>
<tr>
<td>odt_i</td>
<td>In</td>
<td>4</td>
<td>On-die Termination input</td>
</tr>
<tr>
<td>reset_n_i</td>
<td>In</td>
<td>1</td>
<td>DDR Reset input</td>
</tr>
<tr>
<td>write_dqs_oe_n_i</td>
<td>In</td>
<td>DW/2</td>
<td>Tristate control port for DQS</td>
</tr>
<tr>
<td>write_dqs_i</td>
<td>In</td>
<td>DW</td>
<td>Parallel DQS input</td>
</tr>
<tr>
<td>write_dq_oe_n_i</td>
<td>In</td>
<td>DW/2</td>
<td>Tristate control port for DQ/DMI</td>
</tr>
<tr>
<td>Pin Name</td>
<td>Direction</td>
<td>Width (Bits)</td>
<td>Description</td>
</tr>
<tr>
<td>------------------</td>
<td>-----------</td>
<td>-------------</td>
<td>-----------------------------------------------------------------------------</td>
</tr>
<tr>
<td>write_dmi_i</td>
<td>In</td>
<td>DW</td>
<td>Data Mask inversion input.</td>
</tr>
<tr>
<td>write_dq_i</td>
<td>In</td>
<td>8*DW</td>
<td>Parallel data bus input.</td>
</tr>
<tr>
<td>read_dqs_ie_i</td>
<td>In</td>
<td>4</td>
<td>Read enable signal for capturing the incoming read BL16. Each bit captures the DQ/DMI for the corresponding ddr_ck_o cycle. Please refer to DQS Read Training for more information.</td>
</tr>
<tr>
<td>read_dmi_o</td>
<td>Out</td>
<td>DW</td>
<td>Data Mask Inversion output.</td>
</tr>
<tr>
<td>read_dq_o</td>
<td>Out</td>
<td>8*DW</td>
<td>Parallel data bus output.</td>
</tr>
<tr>
<td>read_data_valid_o</td>
<td>Out</td>
<td>DW/8</td>
<td>Data valid flag for READ mode.</td>
</tr>
<tr>
<td><strong>DQS Group Training</strong></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>pause_i</td>
<td>In</td>
<td>1</td>
<td>Set this to 1 to stop the DQSBUF-generated internal clocks when updating rd_clksel_i and the delay codes. This is to avoid metastability.</td>
</tr>
<tr>
<td>rd_clksel_i</td>
<td>In</td>
<td>4</td>
<td>Used to select read clock source and polarity control.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>[1:0]: selects the 0, 45, 90, and 135 (2b00 to 2b11 respectively) degree paths from the DQS write section delay cell.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>[2] = 1b0: use inverted clock</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>[2] = 1b1: use non-inverted clock – adds 180 degree shift</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>[3] = 1b0: bypasses the register in the read enable path</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>[3] = 1b1: selects the register in the read enable path</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>Please refer to DQS Read Training for more information.</td>
</tr>
<tr>
<td>burst_det_sclk_o</td>
<td>Out</td>
<td>DW/8</td>
<td>Clock generated using burst_det_o.</td>
</tr>
<tr>
<td>dqsgroup_vref_i</td>
<td>In</td>
<td>7</td>
<td>Controls I/O drive strength of data I/O path signals by changing the internal voltage reference.</td>
</tr>
<tr>
<td>rd_load_n_i</td>
<td>In</td>
<td>DW/8</td>
<td>Asynchronously resets the delay code according to the Dynamic Margin Control attribute for DQS-DQ skew compensation in read data path.</td>
</tr>
<tr>
<td>rd_move_i</td>
<td>In</td>
<td>DW/8</td>
<td>At rising edge, it changes (+/- 1) the delay code according to rd_dir_i signal for DQS-DQ in read data path.</td>
</tr>
<tr>
<td>rd_dir_i</td>
<td>In</td>
<td>DW/8</td>
<td>Controls the direction of delay code change for DQS-DQ skew compensation in read data path.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>‘0’ to increase and ‘1’ to decrease the delay code.</td>
</tr>
<tr>
<td>rd_cout_o</td>
<td>Out</td>
<td>DW/8</td>
<td>Margin test output flag to indicate the under-flow or over-flow in delay code for DQS-DQ skew compensation in read data path.</td>
</tr>
<tr>
<td>wr_load_n_i</td>
<td>In</td>
<td>DW/8</td>
<td>Reset the delay code according to the Dynamic Margin Control attribute for DQS-DQ skew compensation in write data path.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>A pulse (Low-High-Low) in wr_move_i is needed to perform reset.</td>
</tr>
<tr>
<td>wr_move_i</td>
<td>In</td>
<td>DW/8</td>
<td>At rising edge, it changes (+/- 1) the delay code according to wr_dir_i signal for DQS-DQ skew compensation in write data path.</td>
</tr>
<tr>
<td>wr_dir_i</td>
<td>In</td>
<td>DW/8</td>
<td>Controls the direction of delay code change for DQS-DQ skew compensation in write data path.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>‘0’ to increase and ‘1’ to decrease the delay code.</td>
</tr>
<tr>
<td>wr_cout_o</td>
<td>Out</td>
<td>DW/8</td>
<td>Margin test output flag to indicate the under-flow or over-flow in delay code for DQS-DQ skew compensation in write data path.</td>
</tr>
<tr>
<td>wrlvl_load_n_i</td>
<td>In</td>
<td>DW/8</td>
<td>Asynchronously resets the delay code to factory default value for CK-DQS skew compensation – Write Leveling.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>Note: The reset value is 0 (subject for revision).</td>
</tr>
<tr>
<td>wrlvl_move_i</td>
<td>In</td>
<td>DW/8</td>
<td>At rising edge, it changes (+/-1) the delay code according to the direction set by wrlvl_dir_i for CK-DQS skew compensation – Write Leveling.</td>
</tr>
<tr>
<td>wrlvl_dir_i</td>
<td>In</td>
<td>DW/8</td>
<td>Controls the direction of delay code change for CK-DQS skew compensation (Write Leveling) in write data path.</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>‘0’ to increase and ‘1’ to decrease the delay code.</td>
</tr>
<tr>
<td>wrlvl_cout_o</td>
<td>Out</td>
<td>DW/8</td>
<td>Margin test output flag to indicate the under-flow or over-flow for CK-DQS skew compensation – Write Leveling.</td>
</tr>
</tbody>
</table>
### Pin Name | Direction | Width (Bits)$^1$ | Description
--- | --- | --- | ---
$\text{dqwl}_o^4$ | Out | DW | Data output of write leveling.

#### Per Bit DQ/DMI Training
- $\text{dq_out_adj_load}_n^1_i^2$ | In | DW | DQ output delay per bit adjustment load signal.
- $\text{dq_out_adj_move}_i^2$ | In | DW | DQ output delay per bit adjustment signal.
- $\text{dq_out_adj_dir}_i^2$ | In | DW | DQ output delay per bit adjustment direction signal.
- $\text{dmi_out_adj_cout}_o^2,4^3$ | Out | DW | DQ output delay per bit adjustment cout signal.
- $\text{dmi_out_adj_load}_n^1_i^2$ | In | DW/8 | DMI output delay per bit adjustment load signal.
- $\text{dmi_out_adj_move}_i^2$ | In | DW/8 | DMI output delay per bit adjustment move signal.
- $\text{dmi_out_adj_dir}_i^2$ | In | DW/8 | DMI output delay per bit adjustment direction signal.
- $\text{dmi_out_adj_cout}_o^2,4^3$ | Out | DW/8 | DMI output delay per bit adjustment cout signal.
- $\text{dqs_out_adj_load}_n^1_i^2$ | In | DW/8 | DQS output delay per bit adjustment load signal.
- $\text{dqs_out_adj_move}_i^2$ | In | DW/8 | DQS output delay per bit adjustment move signal.
- $\text{dqs_out_adj_dir}_i^2$ | In | DW/8 | DQS output delay per bit adjustment direction signal.
- $\text{dqs_out_adj_cout}_o^2,4^3$ | Out | DW/8 | DQS output delay per bit adjustment cout signal.
- $\text{dq_in_adj_load}_n^1_i^3$ | In | DW | DQ input delay per bit adjustment load signal.
- $\text{dq_in_adj_move}_i^3$ | In | DW | DQ input delay per bit adjustment signal.
- $\text{dq_in_adj_dir}_i^3$ | In | DW | DQ input delay per bit adjustment direction signal.
- $\text{dmi_in_adj_cout}_o^3,4^3$ | Out | DW | DMI input delay per bit adjustment cout signal.
- $\text{dmi_in_adj_load}_n^1_i^3$ | In | DW/8 | DMI input delay per bit adjustment load signal.
- $\text{dmi_in_adj_move}_i^3$ | In | DW/8 | DMI input delay per bit adjustment move signal.
- $\text{dmi_in_adj_dir}_i^3$ | In | DW/8 | DMI input delay per bit adjustment direction signal.

#### Command Bus Training
- $\text{cs_adj_load}_n^1_i^3$ | In | 1 | CS delay adjustment load signal.
- $\text{cs_adj_move}_i^3$ | In | 1 | CS delay adjustment signal.
- $\text{cs_adj_dir}_i^3$ | In | 1 | CS delay adjustment direction signal.
- $\text{cs_adj_cout}_o^3,4^3$ | Out | 1 | CS delay adjustment cout signal.
- $\text{ca_adj_load}_n^1_i^3$ | In | 6 | CA delay per bit adjustment load signal.
- $\text{ca_adj_move}_i^3$ | In | 6 | CA delay per bit adjustment signal.
- $\text{ca_adj_dir}_i^3$ | In | 6 | CA delay per bit adjustment direction signal.
- $\text{ca_adj_cout}_o^3,4^3$ | Out | 6 | CA delay per bit adjustment cout signal.

#### LPDDR4 Interface
- $\text{ddr_cx}_o$ | Out | 1 | LPDDR4 Clock output (CK). This becomes differential pair signal at the FPGA IO pad.
- $\text{ddr_cke}_o$ | Out | 1 | LPDDR4 Clock Enable output (CKE).
- $\text{ddr_cs}_o$ | Out | 1 | LPDDR4 Chip Select output (CS).
- $\text{ddr_ca}_o$ | Out | 6 | LPDDR4 Command/Address output (CA).
- $\text{ddr_odt}_o$ | Out | 1 | LPDDR4 On-Die Termination Control output (ODT).
- $\text{ddr_reset}_n$ | Out | 1 | LPDDR4 Reset output (RESET_n)
- $\text{ddr_dq}_i$ | In/Out | DW | LPDDR4 Data Input/Output (DQ).
- $\text{ddr_dqs}_i$ | In/Out | DW/8 | LPDDR4 Data Strobe Input/Output (DQS). This signal becomes differential pair at the IO FPGA pad.
- $\text{ddr_dmi}_i$ | In/Out | DW/8 | LPDDR4 Data Mask Inversion Input/Output (DMI).

**Notes:**
1. DW = Data Bus Width attribute
2. These signals are connected to OUTDELAYA primitive, refer to the Signal Description section for the signal description.
3. These signals are connected to DELAYA primitive, refer to the Signal Description section for the signal description.
4. All the *cout_o and dqwl_o signals must be registered directly before driving other logic.
### 2.3. Attribute Summary

#### Table 2.2. Attribute Table

<table>
<thead>
<tr>
<th>Attribute</th>
<th>Selectable Values</th>
<th>Default</th>
<th>Dependency on Other Attributes</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>General Tab</strong></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>General Group</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>I/O Buffer Type</td>
<td>LVSTL_I, LVSTL_II</td>
<td>LVSTL_I</td>
<td></td>
</tr>
<tr>
<td>Gearing Ratio</td>
<td>8:1</td>
<td>8:1</td>
<td>Display Information only</td>
</tr>
<tr>
<td>Data Bus Width</td>
<td>16, 32, 64</td>
<td>16</td>
<td></td>
</tr>
<tr>
<td>Number of DQS Group</td>
<td>Calculated = (Data Bus Width)/8</td>
<td>N/A</td>
<td>Data Bus Width</td>
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<td>Enable Dynamic Margin Control on Clock Delay</td>
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<td></td>
<td></td>
</tr>
<tr>
<td>Enable Per Bit Delay Adjustment on DQS Group</td>
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<td></td>
<td></td>
</tr>
<tr>
<td>Enable Per Bit Delay Adjustment on CA Group</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td><strong>Clock Settings Group</strong></td>
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<td></td>
<td></td>
</tr>
<tr>
<td>DDR Memory Frequency (MHz)</td>
<td>200, 250, 300, 350, 400, 533</td>
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</tr>
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<td>System Clock Frequency (MHz)</td>
<td>Calculated = (DDR Memory Frequency) / Gearing Ratio</td>
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<td>Display Information only</td>
</tr>
<tr>
<td>Enable PLL</td>
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<td></td>
<td></td>
</tr>
<tr>
<td>PLL Input Frequency*</td>
<td>10 – 800</td>
<td>100</td>
<td></td>
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<td>PLL Reference Clock from Pin</td>
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<td></td>
<td></td>
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<tr>
<td>PLL Reference Clock I/O Type</td>
<td>LVSTL_I, LVSTL_II, LVSTLD_I, LVSTLD_II, LVTTL33, LVC莫斯33, LVC莫斯25, LVC莫斯18, LVC莫斯18H, HSTL15D_I, LVC莫斯15, LVC莫斯15H, LVCmos12, LVCmos12H, LVCmos10H, LVCmos10, LVCmos10R</td>
<td>LVSTL_I</td>
<td>PLL Reference Clock from I/O Pin are both Checked</td>
</tr>
<tr>
<td>Clock Output Tolerance (%)</td>
<td>0.0, 0.1, 0.2, 0.5, 1.0, 2.0, 5.0, 10.0</td>
<td>0.1</td>
<td>‘Enable PLL’ is Checked</td>
</tr>
<tr>
<td>DDR Memory Actual Frequency (MHz)</td>
<td>Calculated</td>
<td>N/A</td>
<td>Display Information only</td>
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<tr>
<td><strong>Clock/Address/Command</strong></td>
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<td></td>
</tr>
<tr>
<td>Number of Clocks</td>
<td>1, 2, 4</td>
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<td></td>
</tr>
<tr>
<td>Address Width</td>
<td>6</td>
<td>6</td>
<td>Display Information only</td>
</tr>
<tr>
<td>Number of Chip Selects</td>
<td>1, 2, 4</td>
<td>1</td>
<td></td>
</tr>
<tr>
<td>Number of Chip ODT</td>
<td>1</td>
<td>1</td>
<td>Display Information only</td>
</tr>
<tr>
<td><strong>Dynamic Margin Control</strong></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>DQS Read Delay Adjustment Enable</td>
<td>Checked, Unchecked</td>
<td>Unchecked</td>
<td>Enable Dynamic Margin Control on Clock Delay is Checked</td>
</tr>
<tr>
<td>DQS Read Delay Adjustment Sign</td>
<td>POSITIVE, COMPLEMENT</td>
<td>POSITIVE</td>
<td>DQS Read Delay Adjustment Enable is Checked</td>
</tr>
<tr>
<td>DQS Read Delay Adjustment Value</td>
<td>0 to 255</td>
<td>0</td>
<td></td>
</tr>
</tbody>
</table>
### 2.4. DDR Memory Primitives

This section briefly describes the Lattice FPGA primitives that are used to implement the LPDDR4 Memory Module. Please refer to Reference Guides > FPGA Libraries Reference Guide > Primitive Library - <Device Name> of the Lattice Radiant Software Help for more information on these FPGA primitives. **Figure 2.3** navigates the LFCPNX Primitive Library from the Lattice Radiant Software Help.

![Reference Guide for the Primitive Library](image)

**Figure 2.3. Reference Guide for the Primitive Library**

*Note: The PLL Input Frequency attribute is fixed to 100 MHz for IP Core v1.0.0. This option to be enabled to support multiple frequencies in the next release.*

<table>
<thead>
<tr>
<th>Attribute</th>
<th>Selectable Values</th>
<th>Default</th>
<th>Dependency on Other Attributes</th>
</tr>
</thead>
<tbody>
<tr>
<td>DQS Read Delay Adjustment Actual Value</td>
<td>Calculated</td>
<td></td>
<td>Display Information only</td>
</tr>
<tr>
<td>DQS Write Delay Adjustment Enable</td>
<td>Checked, Unchecked</td>
<td>Unchecked</td>
<td>Enable Dynamic Margin Control on Clock Delay is Checked</td>
</tr>
<tr>
<td>DQS Write Delay Adjustment Sign</td>
<td>POSITIVE, COMPLEMENT</td>
<td>POSITIVE</td>
<td>DQS Write Delay Adjustment Enable is Checked</td>
</tr>
<tr>
<td>DQS Write Delay Adjustment Value</td>
<td>0 to 255</td>
<td>0</td>
<td>Display Information only</td>
</tr>
<tr>
<td>DQS Write Delay Adjustment Actual Value</td>
<td>Calculated</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>
2.4.1. Input/Output DELAY

The DELAY blocks can be used to delay the signal in either of the following paths:
- Delay the input signal – from the input pin to the IDDR or IREG or FPGA Fabric
- Delay the output signal – from the ODDR, OREG or FPGA fabric to the output pin

This is useful to adjust for any skews amongst the input or output data bus. It can also be used to generate skew between the bits of output bus to reduce SSO noise. The DELAY block can be used with IDDR or ODDR modules, SDR module, as well as on the direct input pin of the FPGA. The DELAY is shared by the input and output paths and hence can only be used either to delay the input data or the output signal on a given pin.

The delayed value are set using:
- Pre-determined delay value (for Zero Hold time, delay based on Interface Type)
- Fixed delay values entered by user
- Dynamically updated using counter up and down controls

The DELAY block can be completely bypassed as well.

2.4.1.1. DELAYA

By default, the DELAYA primitive is configured to factory delay settings based on the clocking structure. Users can update the DELAY setting using the MOVE and DIRECTION control inputs. The LOAD_N resets the delay back to the default value.

2.4.1.2. DELAYB

The DELAYB primitive is be configured to factory delay settings based on the clocking structure. Users cannot change the delay when using this module.

2.4.1.3. OUTDELAYA

The OUTDELAYA primitive is used to add static and dynamic delay to DOUT and TOUT for write training in LPDDR4 mode.
2.4.2. IDDR/ODDR

This section describes the primitives used to build LPDDR2, DDR3 and LPDDR4 memory interfaces. Some of these primitives are also used to generate generic DDR functions that use DQS clocking tree. The IDDR/ODDR primitives support 4:1(X2), 8:1(X4), gearing modes that are used to implement the memory functions. The gearing mode defines the ratio of system clock and DDR clock frequencies. The data from the FPGA fabric transferred using the rising edge of system clock (slower frequency) while the data in DDR interface side is transferred in both edges of the DDR clock (faster frequency).

A 4:1 (X2) gearing mode means:
- Clock frequency ratio: 1 system clock : 2 DDR clock
- Data bit width ratio: 4 bits of data in system clock rising edge: 1 bit of data in for each of 4 DDR clock edges

Similarly, an 8:1 (X4) gearing mode means:
- Clock frequency ratio: 1 system clock : 8 DDR clock
- Data bit width ratio: 8 bits of data in system clock rising edge: 1 bit of data in for each of 8 DDR clock edges

Thus, it is recommended to use X4 gearing mode when a low system clock frequency or a high DDR clock frequency is desired.

2.4.2.1. IDDRX4DQ

This primitive is used to capture the data bits from DDR3 or LPDDR4 interface for X4 gearing mode.

```
IDDRX4DQ
D     Q0
DQS90 Q1
ECLK  Q2
SCLK  Q3
RST   Q4
RDPNTR[2:0] Q5
WRPNTR[2:0] Q6
```

Figure 2.7. IDDRX2DQ Block Diagram
2.4.2.2. ODDRX4DQ

This primitive is used to generate the DQ data output of DDR3 or LPDDR4 memory interface for X4 gearing mode.

![ODDRX4DQ Block Diagram](image)

- **D0**
- **D1**
- **D2**
- **D3**
- **D4**
- **D5**
- **D6**
- **D7**
- **DQSW270**
- **ECLK**
- **SCLK**
- **RST**

**Figure 2.8. ODDRX4DQ Block Diagram**

2.4.3. ODDRX4DQS

This primitive is used to generate DQS clock output of DDR3 and LPDDR4 memory for X4 gearing.

![ODDRX4DQS Block Diagram](image)

- **D0**
- **D1**
- **D2**
- **D3**
- **D4**
- **D5**
- **D6**
- **D7**
- **DQSW**
- **ECLK**
- **SCLK**
- **RST**

**Figure 2.9. ODDRX4DQS Block Diagram**

2.4.4. Memory Output DDR Primitives for Tristate Output Control

The following are the primitives used to implement tristate control for the outputs to the DDR memory.

2.4.4.1. TSHX4DQ

This primitive is used to generate the tristate control for DQ data output of DDR3 memory interface with x4 gearing mode.

![TSHX4DQ Block Diagram](image)

- **T0**
- **T1**
- **T2**
- **T3**
- **DQSW270**
- **ECLK**
- **SCLK**
- **RST**

**Figure 2.10. TSHX4DQ Block Diagram**
2.4.4.2. TSHX4DQS
This primitive is used to generate the tristate control to DQS output for DDR3 or LPDDR4 memory interface for x4 gearing mode.

![TSHX4DQS Block Diagram](image)

Figure 2.11. TSHX4DQS Block Diagram

2.4.5. OSHX4
This primitive is used to generate the address and command signals of DDR3 or LPDDR4 memory interface for x4 gearing mode and write leveling.

![OSHX4 Block Diagram](image)

Figure 2.12. OSHX4 Block Diagram

2.4.6. DDRDLL
DDRDLL generates a phase shift code (90 degree) according to its running frequency. This code is provided to every individual DQS block and DLLDEL slave delay element located in 2 adjacent sides if available.

![DDRDLL Block Diagram](image)

Figure 2.13. DDRDLL Block Diagram
2.4.7. ECLKDIV

![ECLKDIV Block Diagram](image)

**ECLKDIV**

- DIVRST
- ECLKIN
- SLIP
- TESTINP[3:0]
- DIVOUT

Figure 2.14. ECLKDIV Block Diagram

2.4.8. ECLKSYNC

![ECLKSYNC Block Diagram](image)

**ECLKSYNC**

- ECLKIN
- STOP
- ECLKOUT

Figure 2.15. ECLKSYNC Block Diagram

2.4.9. DQSBUF_IVREF

To support DDR memory interfaces (DDR2/3, LPDDR2/3/4), the DQS strobe signal from the memory must be used to capture the data (DQ) in the PIC registers during memory reads.

![DQSBUF_IVREF Block Diagram](image)

**DQSBUF_IVREF**

- DQSI
- PAUSE
- RDCKSEL[3:0]
- RDDIR
- RDLOADN
- READ[3:0]
- READMOVE
- RST
- SCLK
- SECLK
- WRDIR
- WRLVDIR
- WRLLOAD_N
- WRLVLOAD_N
- WRMOVE
- WRLMOVE
- ECLKIN
- RSTSMCNT
- DLLCODE[8:0]
- IVREF[6:0]
- BTDetect
- BURSTDETECT
- DATAVALID
- DQSW
- DQSWRD
- RDPNTR(2:0)
- READCOUT
- DQSR90
- DQSW270
- WRCOUT
- WRLVCOUT
- WRPNTR(2:3)

Figure 2.16. DQSBUF_IVREF Block Diagram
2.5. Clock Synchronization Logic

Figure 2.17 shows the block diagram of the clock synchronization logic. The PLL generates the following clocks:

- **CLKOP** – a slow clock equal to the frequency of the reference lock – set by *PLL Input Frequency* attribute. This clock is used to clock the MEM_SYNC.
- **CLKOS** – used for sclk_o and eclk_o (internal DDR clock that clocks the DDR primitives) generation. The CLKOS frequency is set by *DDR Memory Frequency* attribute, which is the operating clock. The CLKOS frequency is selectable between operating clock (*DDR Memory Frequency*) and 50 MHz which is the command bus training clock.

The ECLKSYNC and ECLKDIV generates the eclk_o and sclk_o respectively. These clocks are routed to a dedicated clock route resource which ensures correct timing. The DDRDLL generates the DLL code which is used by the DQSBUF for generating the correct phase delays of the internal clocks for the data path. These DDR clock primitives are controlled by MEM_SYNC which is implemented in soft logic.

![Clock Synchronization Logic Block Diagram](image)

Figure 2.17. Clock Synchronization Logic Block Diagram

An example of clock frequency change timing diagram is shown in Figure 2.18, the order of signal transitions are accurate but the cycle by cycle relationship is not. This is because the signals are operating in 3 clock – sclk_o, internal eclk_o (CLKOS) and CLKOP (not shown). The signals moving across clock domains avoid metastability by implementing clock crossing logic or only allow transition during freeze/stop/pause signals are asserted.

The clock frequency change is initiated by a Low to High transition on clk_update_i signal and the ddr_clk_sel_i specifies the target new frequency: 1'b0 for Operating Frequency and 1'b1 for command bus training frequency. The ready_o signal negates in the next sclk_o cycle, indicating that the sclk_o and ddr_clk_o are not yet ready. The controller must not issue any request - command/data/delay code update while ready_o signal is low. The MEM_SYNC.freeze signal asserts and is followed by MEM_SYNC.stop assertion to properly stop the sclk_o and eclk_o before the actual PLL clock change which occurs during both freeze and stop signals asserted. When these signals are negated, the PLL is already generating the target frequency. The sclk_o and ddr_clk_o resumes at the target frequencies.
The DLL code need to be updated for the new frequency. This is done by asserting the MEM_SYNC.dll_reset, the pause signal is asserted before and after dll_reset to avoid metastability. The DDRDLL.lock negates after the dll_reset and asserts after the DDRDLL locks to the new frequency. The MEM_SYNC.uddcntln pulses to update the DLL code, the pause_o is also asserted before and after this pulse for the DQSBUF to properly update for the new DLL code.

The ready_o signal asserts to indicate that the clocks are now stable and the module is now ready to receive new requests from the controller. The clk_update_i may be negated any time after the ready_o signal asserts.

2.6. Data Input/Output Path

The block diagram of Data Input/Output Path describing the DDR primitives connections are shown in Figure 2.19.
The DQSBUF_IVREF generates the following 3 internal clocks which are generated according to the DLL code:

- **DQSW** – clocks the write DQS. The delay is controlled by the wrvlwrld_load_n/move/dir> signals (write leveling).
- **DQSW270** – clocks the write DQ/DMI. The delay is controlled by the wrld_load_n/move/dir> signals
- **DQSR90** – clocks the read DQ/DMI. The delay is controlled by the rdld_load_n/move/dir> signals

This internal clock is only activated when a read pre-amble DQS=0 followed by DQS pulse has been successfully captured. A read BL16 produces eight DQSR90 pulses.

**Important Note:**

The delay codes of DQSBUF_IVREF is not initialized during reset. The controller or user logic must reset the delay codes by driving 0 logic to wrvlwrld_load_n, wrld_load_n and rdld_load_n before performing any training.
2.6.1. Write Data access

Figure 2.20 shows the timing diagram example for write BL16 data access with Data Bus Width = 32 (DQS group = 4). The pre-amble is 2nCK cycles and the post amble for this example is 0.5nCK. The 2nCK pre-amble is generated by setting write_dqs_i = 0xFF. F during disable cycle and enabling DQS 1 CK earlier than the DQ/DMI. The input is internally registered at the first rising edge of sclk_o and is outputted serially after 2 sclk_o cycles. Thus, the latency is 3 sclk_o cycles. The output enable signal write_dq_oe_n_i and write_dq_oe_n_i are 4x the bit width of the DQS group (DW/8).

Adding 1 ddr_ck_o cycle latency in DDR side means shifting the inputs in the User Interface side. For example the Figure 2.21 is equal to Figure 2.20 with added 2nCK latency.

![Figure 2.20. Write BL16 timing diagram](image)

![Figure 2.21. Write BL16 timing diagram with added 2nCK latency](image)

2.6.2. Read Data access

The read_dqs_ie_i signals the DQSBUF to capture the incoming read burst, the bits[3:0] indicates that corresponding DDR clock cycle is captured. In Figure 2.22, read_dqs_ie_i = 4’hF for 2 consecutive SCLK cycles, starting from sclk_o rising edge at tick 9. This means the 8x2=16 samples of DQ/DMI are captured continuously starting from next rising edge of internal DDR clock for read path after the sclk_o rising edge at tick 25 – this is 3 SCLK rising edge including the 1st, read_dqs_ie_i = 4’hF sample. The pre-amble with a DQS pulse must be provided before this time.

![Figure 2.22. Read BL16 timing diagram (rd_clksel_i=4’h0)](image)

When the read preamble and eight DQS pulses are captured properly, burst_det_sclk_o asserts for two sclk_o cycles or more. If burst_det_sclk_o did not assert or has asserted for only 1 sclk_o cycle, that means the captured read DQ/DMI is unreliable. The timing of assertion of burst_det_sclk_o depends on asynchronous (with respect to sclk_o) reception of the incoming burst. Thus, actual assertion time is difficult to predict. Because of this, this signal is only used during DQS Read Training and Read Training.
The read_data_valid_o asserts when eight DQ/DMI samples has been captured, this signal should assert for 2 sclk_o cycles when a read BL16 has been captured properly. The read_dq_o and read_dmi_o are don’t care when read_data_valid_o is negated. The eight DQ/DMI samples are transferred in 1 sclk_o cycles in the read_dq_o/read_dmi_o signals with the first sample on the LSB side.

The Figure 2.23 is similar to Figure 2.22 except that the read_clksel_i is 4’hF which shifts the correct BL16 position by 2 ddr_ck_o cycles. The read_clksel_i is like a phase delay adjustment of $2 \times 360^\circ / 16 = 45^\circ$ for each step.

![Figure 2.23. Read BL16 timing diagram (rd_clksel_i =4’hF)](image)

### 2.6.3. DQS Read Training

For every read operation, the LPDDR4 Memory Interface Module must be initialized at the appropriate time to identify the incoming read DQS pre-amble. Upon a proper detection of the pre-amble, the DQSBUF extracts a clean signal out of the incoming DQS signal from the memory and generates the necessary control signals to the other primitives for capturing the DQ/DMI. The incoming read data is asynchronous to sclk_o but upon proper positioning of the read_dqs_ie_i and rd_clksel_i, the captured data is aligned to BL8. Thus, no more data alignment is needed on the outputs read_dq_o and read_dmi_o.

The DQS read training process sweeps all the read_dqs_ie_i and rd_clksel_i combination to determine this appropriate time that the incoming preamble and eight DQS pulses can be cleanly captured. Below is the DQS read training procedure:

1. Update the rd_clksel_i value, each increment is approximately $45^\circ$ phase shift. The following steps must be followed when updating the rd_clksel_i to avoid metastability:
   a. Assert the pause_i signal to stop the internal clocks.
   b. Wait for 4 sclk_o cycles
   c. Change the rd_clksel_i to new value. This is usually increment by 1.
   d. Wait for 4 sclk_o cycles
   e. Negate the pause_i signal to enable the internal clocks.

2. Trigger the LPDDR4 memory to send BL16.

3. Capture the incoming BL16 using the read_dqs_ie_i signal. Each bit of the read_dqs_ie_i[3:0] signal aligns to one ddr_ck_o cycle. For a burst length of 16 (BL16), a total of 2 SCLK cycle of read_dqs_ie_i=4’F needs to be provided. Below are the valid sequences, depending on the position of the incoming pre-amble, each have consecutive 8 bits asserted:
   a. Cycle 1: 4’b1000, Cycle 2: 4’b1111, Cycle 3: 4’b0111
   b. Cycle 1: 4’b1100, Cycle 2: 4’b1111, Cycle 3: 4’b0011
   c. Cycle 1: 4’b1110, Cycle 2: 4’b1111, Cycle 3: 4’b0001
   d. Cycle 1: 4’b1111, Cycle 2: 4’b1111

4. If burst_det_clk_o asserts for at least 2 sclk_o cycles, that means the preamble and BL16 has been properly captured. If the read data is correct, DQS Read Training is done, otherwise, proceed to next step.

5. Repeat Steps 2-4 until all the possible rd_clksel_i sequences are swept or until DQS Read Training done in Step 4.

6. Repeat Steps 2-4 until all the possible read_dqs_ie_i values are swept or until DQS Read Training done in Step 4.
2.7. Command/Address Path

Figure 2.24 shows the block diagram of the command/address path. The Clock is generated by the ODDRX4, the toggle starts from ‘0’ so that values in other signals are shifted out in the ddr_ck_o falling edge and are sampled by the external LPDDR4 memory device on the rising edge for better skew tolerance. Other signals are connected to OSHX4 which means each bit (6 bits for CA) are shifted out in each clock cycle. The DELAYB is for correcting the internal skew after silicon validation. The DELAYA is used for delay adjustment during command bus training. The timing diagram of command/address path is shown in Figure 2.25.
2.8. Training Support

2.8.1. Command Bus Training

This section describes the LPDDR4 Memory Module’s support for command bus training, focusing on the Step 5 of Training Sequence for single-rank systems as described in the section 4.9.1 of the LPDDR4 Standard which says: “Perform Command Bus Training ($V_{\text{REF}}\text{CA}$, CS, and CA)".

This step is broken down to the following sub-steps:

- Program the LPDDR4 Memory $V_{\text{REF}}\text{CA}$ – refer to Figure 2.26
- Send CA pattern and capture the feedback value from LPDDR4 Memory – refer to Figure 2.27
- Adjustment of the CA Bus Delay Code

![Figure 2.25. Command/Address Path Timing diagram](image_url)

![Figure 2.26. LPDDR4 Memory $V_{\text{REF}}\text{CA}$ Programming Timing Diagram](image_url)

![Figure 2.27. Sending/Capture a CA Pattern Timing Diagram](image_url)
3. Core Generation, Simulation, and Validation

This section provides information on how to generate the LPDDR4 Memory Module using the Lattice Radiant software and how to run simulation and synthesis.

3.1. Licensing the IP

No license is required for this module.

3.2. Generation and Synthesis

Lattice Radiant Software allows you to generate and customize modules and IPs and integrate them into the device architecture.

To generate the LPDDR4 Memory Module in Lattice Radiant Software:

1. In the Module/IP Block Wizard create a new Lattice Radiant Software project for the LPDDR4 Memory module.
2. In the IP Catalog tab, double-click on LPDDR4_MEM under Module, Architecture_Modules, I/O category. The Module/IP Block Wizard opens as shown in Figure 3.1. Enter values in the Component name and the Create in fields and click Next.

![Figure 3.1. Module/IP Block Wizard]

3. In the dialog box of the Module/IP Block Wizard window, configure LPDDR4 Memory module according to custom specifications using drop-down menus and check boxes. As a sample configuration, see Figure 3.2. For configuration options, see Table 2.2.
Figure 3.2. Configure Block of DDR Memory Module

4. Click **Generate**. The **Check Generating Result** dialog box opens, showing design block messages and results as shown in **Figure 3.3**.

Figure 3.3. Check Generating Result
5. Click Finish to generate the Verilog file. All the generated files are placed under the directory paths in the Create in and the Component name fields shown in Figure 3.1.

The generated LPDDR4 Memory Module package includes the black box (<Component name>_bb.v) and instance templates (<Component name>_tmpl.v/vhd) that can be used to instantiate the core in a top-level design. An example RTL top-level reference source file (<Component name>.v) that can be used as an instantiation template for the IP core is also provided. You may also use this top-level reference as the starting template for the top-level for their complete design. The generated files are listed in Table 3.1.

<table>
<thead>
<tr>
<th>Attribute</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>&lt;Component name&gt;.ipx</td>
<td>This file contains the information on the files associated to the generated IP.</td>
</tr>
<tr>
<td>&lt;Component name&gt;.cfg</td>
<td>This file contains the parameter values used in IP configuration.</td>
</tr>
<tr>
<td>component.xml</td>
<td>Contains the ipxact:component information of the IP.</td>
</tr>
<tr>
<td>design.xml</td>
<td>Documents the configuration parameters of the IP in IP-XACT 2014 format.</td>
</tr>
<tr>
<td>rtl/&lt;Component name&gt;.v</td>
<td>This file provides an example RTL top file that instantiates the IP core.</td>
</tr>
<tr>
<td>rtl/&lt;Component name&gt;_bb.v</td>
<td>This file provides the synthesis black box.</td>
</tr>
<tr>
<td>misc/&lt;Component name&gt;_tmpl.v</td>
<td>These files provide instance templates for the IP core.</td>
</tr>
<tr>
<td>eval/eval_top.v</td>
<td>Top level RTL files that may be used for running Lattice Radiant software flow check (synthesis to export) on the generated IP. Without this, the Radiant software map process fails due to not enough I/O. This is mainly used for checking resource utilization and fmax for the selected IP configuration, this is not for implementation.</td>
</tr>
<tr>
<td>eval/lscs_simple_lfsr.v</td>
<td>A simple linear-feedback shift register.</td>
</tr>
<tr>
<td>eval/dut_inst.v</td>
<td>A sample instantiation of the generated IP. This is included by the eval_top.v.</td>
</tr>
<tr>
<td>eval/dut_params.v</td>
<td>Lists the equivalent localparams of the user settings. This is included by the eval_top.v.</td>
</tr>
</tbody>
</table>
3.3. Running Functional Simulation

Below are the steps for running simulation.

1. Add the tb_top.v top level testbench file in the project as a simulation file. Click the File tab and select Add in the drop down menu. Click Existing Simulation File and select <Component name>/testbench/tb_top.v.

2. Click the button located on the Toolbar to initiate the Simulation Wizard shown in Figure 3.4.

![Figure 3.4. Simulation Wizard](image)

3. Click Next to open the Add and Reorder Source window as shown in Figure 3.5. Notice that the Source Files area only contain the generated IP (<Component name>.v) and the tb_top.v, which is added in Step 1. The tb_top.v includes all the necessary test files for simulation.

![Figure 3.5. Adding and Reordering Source](image)
4. Click **Next**. The **Summary** window is shown. Click **Finish** to run the simulation.

The results of the simulation in our example are provided in **Figure 3.6**.

![Figure 3.6. Simulation Waveform](image.png)
Appendix A. Resource Utilization

Table A.1 shows the configuration and resource utilization for LCPNX-100-9FFG672I using Synplify Pro of Lattice Radiant software 2.3.

Table A.1. Resource Utilization

<table>
<thead>
<tr>
<th>Configuration</th>
<th>sclk_o Fmax (MHz)*</th>
<th>Registers</th>
<th>LUTs</th>
<th>EBRs</th>
<th>IDDR/ODDR/TDDR</th>
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</thead>
<tbody>
<tr>
<td>Default</td>
<td>200</td>
<td>49</td>
<td>118</td>
<td>0</td>
<td>18/30/20</td>
</tr>
<tr>
<td>Data Bus Width = 32, Others = Default</td>
<td>200</td>
<td>49</td>
<td>120</td>
<td>0</td>
<td>36/50/40</td>
</tr>
<tr>
<td>Data Bus Width = 64, Others = Default</td>
<td>200</td>
<td>49</td>
<td>118</td>
<td>0</td>
<td>72/90/80</td>
</tr>
<tr>
<td>Data Bus Width = 32, DDR Memory Frequency = 533 MHz, Others = Default</td>
<td>200</td>
<td>49</td>
<td>111</td>
<td>0</td>
<td>36/50/40</td>
</tr>
</tbody>
</table>

*Note: The sclk_o Fmax is generated using a design that only contains the DDR Memory Module and a few linear-feedback shift registers. These values may be reduced when the IP Core is used with the user logic.
References

- CertusPro-NX FPGA Web Page at www.latticesemi.com
Technical Support Assistance
Submit a technical support case through www.latticesemi.com/techsupport.
## Revision History

### Revision 1.1, June 2021

<table>
<thead>
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<th>Section</th>
<th>Change Summary</th>
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<tr>
<td>Introduction</td>
<td>Updated content including Table 1.1 to include CertusPro-NX.</td>
</tr>
<tr>
<td>References</td>
<td>Updated reference to CertusPro-NX.</td>
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### Revision 1.0, December 2020

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<td>All</td>
<td>Initial release</td>
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